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Application/Control No.	Applicant(s)/Patent under Reexamination		
10/531,785	MUCK ET AL.		
Examiner	Art Unit		
Sai Mina Chan	2616		

SEARCHED				
Class	Subclass	Date	Examiner	
370	210	10/16/2007	sc	
update	search	2/1/2008	sc	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST Image and keyword search in USPAT, US_PGPUB, DERWENT, EPO, JPO, and IBM_TDB (see attached search strategy)	10/16/2007	SC		
Inventor name and Assignee search in PALM EXPO and EAST	10/16/2007	SC		
Updated search	2/1/2008	sc		
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